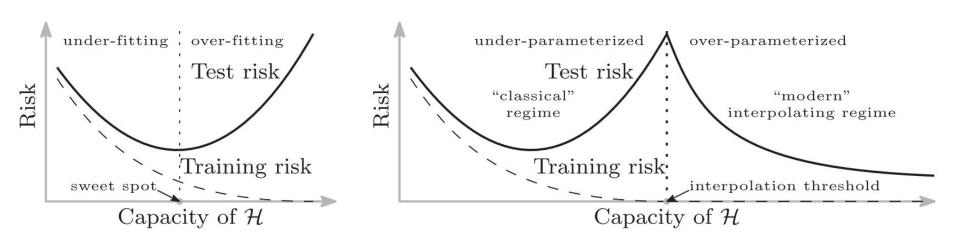
Double Descent

Alexey Voskoboinikov

Double Descent

Classical generalization curve

Modern generalization curve



Belkin, Mikhail, et al. "Reconciling modern machine-learning practice and the classical bias—variance trade-off." *Proceedings of the National Academy of Sciences* 116.32 (2019): 15849-15854.

$$h(x) = \sum_{k=1}^{N} \theta_k \phi(x, v_k)$$

Random Fourier features:

1.
$$\phi(x, v_k) = e^{i\langle x, v_k \rangle}, \quad v_k \sim \mathcal{N}(v_k | 0, \alpha I)$$

2.
$$\phi(x, v_k) = \sqrt{2}\cos(\langle x, v_k \rangle + b_k)$$

$$v_k \sim \mathcal{N}(v_k|0, \alpha I), \quad b_k \sim \mathbf{Unif}(0, 2\pi)$$

Random ReLU features:

3.
$$\phi(x, v_k) = \max(0, \langle x, v_k \rangle)$$

$$v_k \sim \mathcal{N}(v_k | 0, \alpha I)$$

Underparameterized regime

Excess risk:

$$R(\hat{\theta}) = ||\hat{\theta} - \theta^*||_2^2$$

Expected excess risk:

$$\mathbb{E}\left[R(\hat{\theta})\right] = \sigma^2 \mathbb{E}\left[\mathbf{tr}((\Phi^T \Phi)^{-1})\right] = \sigma^2 \frac{d}{n - d - 1}$$

Overparameterized regime

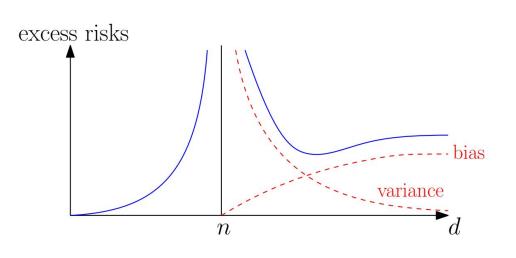
Excess risk:

$$R(\hat{\theta}) = ||\hat{\theta} - \theta^*||_2^2$$

Expected excess risk:

$$\mathbb{E}\left[R(\hat{\theta})\right] = \sigma^2 \frac{n}{d-n-1} + ||\theta^*||_2^2 \frac{d-n}{d}$$

Belkin, Mikhail, et al. "Reconciling modern machine-learning practice and the classical bias-variance trade-off." *Proceedings of the National Academy of Sciences* 116.32 (2019): 15849-15854.



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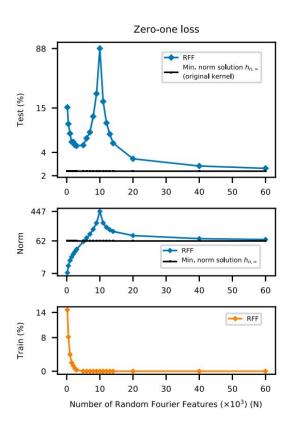
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Overparameterized regime

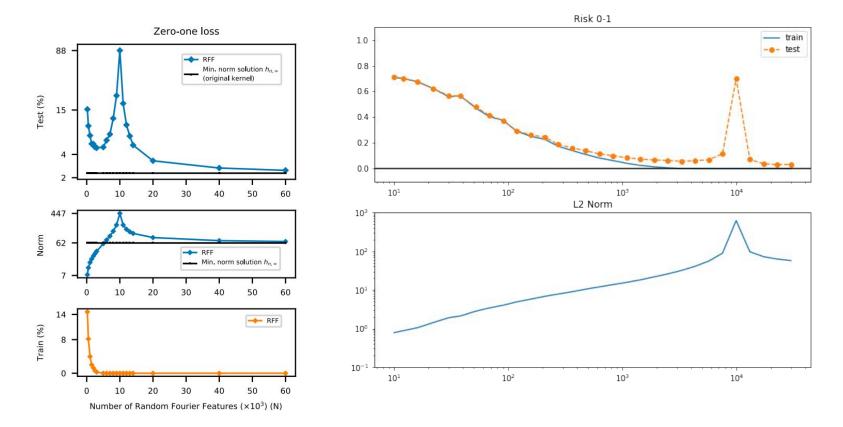
Excess risk:

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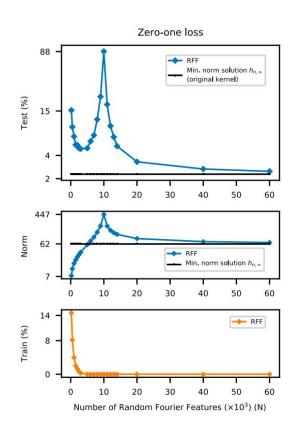
Expected excess risk:

$$\mathbb{E}\left[R(\hat{\theta})\right] = \sigma^2 \frac{n}{d-n-1} + ||\theta^*||_2^2 \frac{d-n}{d}$$

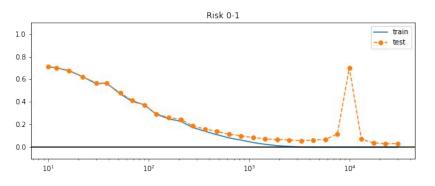
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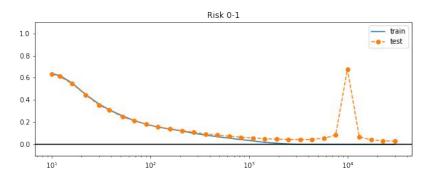
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Random Fourier features

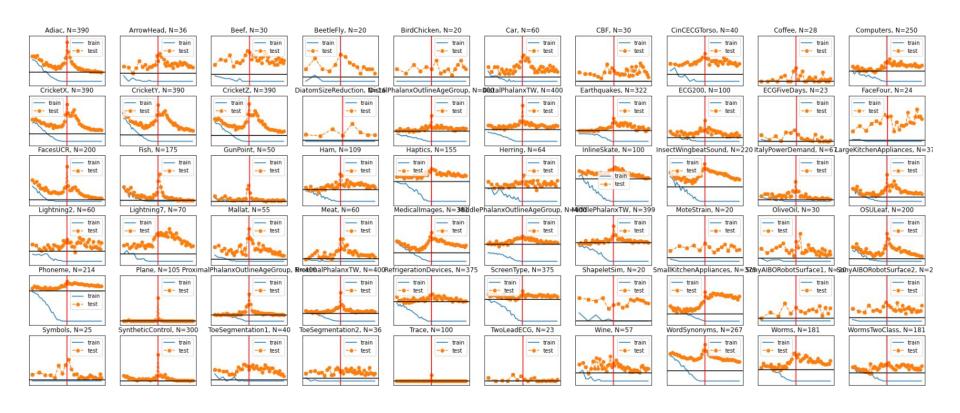


Random Relu features



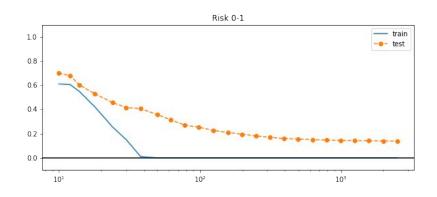
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Rocket

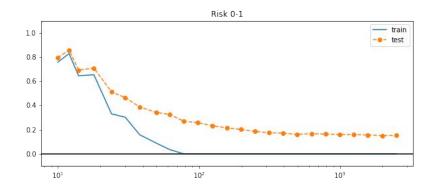


Different models

Logistic Regression

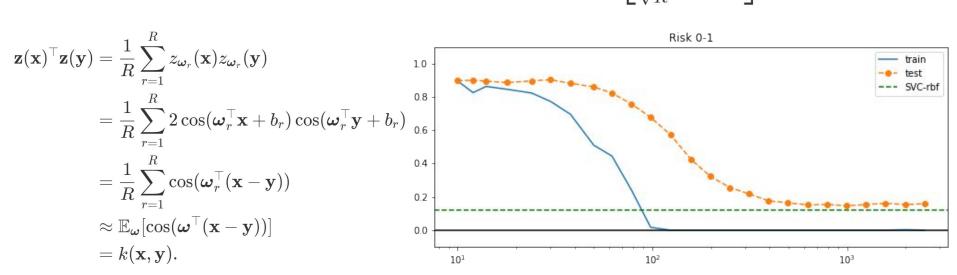


Linear SVM



Linear SVM with RFF

$$egin{aligned} oldsymbol{\omega} & \sim p(oldsymbol{\omega}) \ b & \sim \mathrm{Uniform}(0, 2\pi) \ z_{oldsymbol{\omega}}(\mathbf{x}) & = \sqrt{2}\cos(oldsymbol{\omega}^ op \mathbf{x} + b). \end{aligned} \qquad \mathbf{z}(\mathbf{x}) = egin{bmatrix} rac{1}{\sqrt{R}} z_{oldsymbol{\omega}_1}(\mathbf{x}) \ rac{1}{\sqrt{R}} z_{oldsymbol{\omega}_2}(\mathbf{x}) \ rac{1}{\sqrt{R}} z_{oldsymbol{\omega}_R}(\mathbf{x}) \end{bmatrix}$$



Rahimi, Ali, and Benjamin Recht. "Random features for large-scale kernel machines." Advances in neural information processing systems 20 (2007).